

SN74LV594A-Q1 車載 8 ビット、パラレル出力シリアル・シフト・レジスタ

1 特長

- 車載アプリケーション用に AEC-Q100 認定済み:
 - デバイス温度グレード 1: -40°C ~ +125°C, T_A
 - デバイス HBM ESD 分類レベル 2
 - デバイス CDM ESD 分類レベル C6
- ウェットプル・フランク QFN (WBQB) パッケージで供給
- 2V ~ 5.5V の V_{CC} で動作
- 最大 t_{pd} 6.5ns (5V 時)
- 標準 V_{OLP} (出力グランド・バウンス) < 0.8V ($V_{CC} = 3.3V$, $T_A = 25^\circ C$)
- すべてのポートで混在モード電圧動作をサポート
- ストレージを備えた 8 ビットのシリアル入力パラレル出力シフト・レジスタ
- シフト・レジスタとストレージ・レジスタでの独立した直接オーバーライド・クリア
- シフト・レジスタとストレージ・レジスタ用の独立したクロック
- JESD 78, Class II 準拠で 100mA 超のラッチアップ性能

2 アプリケーション

- 出力拡張
- LED マトリクス制御
- 7 セグメント・ディスプレイ制御

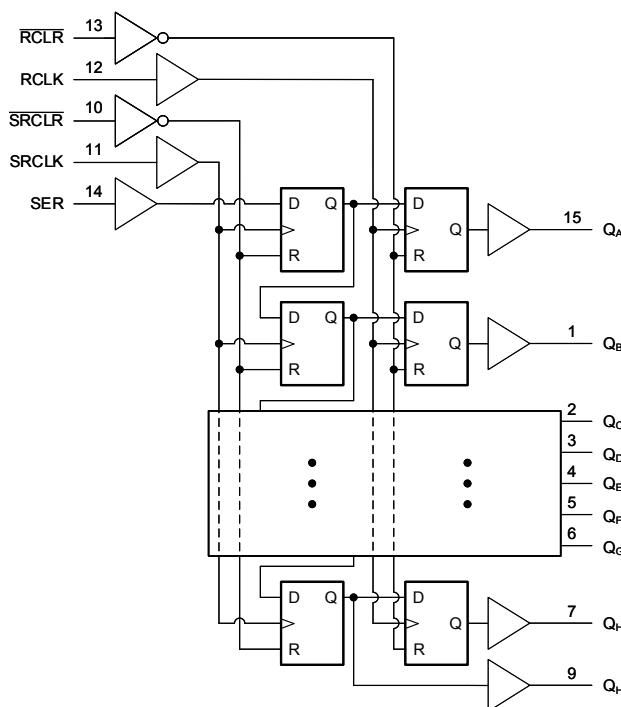
3 概要

SN74LV594A-Q1 デバイスは、2V ~ 5.5V の V_{CC} で動作するように設計された 8 ビットのシフト・レジスタです。

パッケージ情報 (1)

部品番号	パッケージ	本体サイズ (公称)
SN74LV594A-Q1	BQB (WQFN, 16)	3.60mm × 2.60mm

- (1) 利用可能なパッケージについては、このデータシートの末尾にある注文情報を参照してください。



論理図 (正論理)



Table of Contents

1 特長	1	8 Detailed Description	12
2 アプリケーション	1	8.1 Overview.....	12
3 概要	1	8.2 Functional Block Diagram.....	12
4 Revision History	2	8.3 Feature Description.....	13
5 Pin Configuration and Functions	3	8.4 Device Functional Modes.....	13
6 Specifications	4	9 Application and Implementation	14
6.1 Absolute Maximum Ratings.....	4	9.1 Application Information.....	14
6.2 ESD Ratings.....	4	9.2 Typical Application.....	14
6.3 Recommended Operating Conditions.....	5	10 Power Supply Recommendations	16
6.4 Thermal Information.....	5	11 Layout	17
6.5 Electrical Characteristics.....	6	11.1 Layout Guidelines.....	17
6.6 Switching Characteristics: $V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$	6	11.2 Layout Example.....	17
6.7 Switching Characteristics: $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$	7	12 Device and Documentation Support	18
6.8 Switching Characteristics: $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$	7	12.1 Receiving Notification of Documentation Updates..	18
6.9 Timing Requirements: $V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$	8	12.2 サポート・リソース.....	18
6.10 Timing Requirements: $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$	8	12.3 Trademarks.....	18
6.11 Timing Requirements: $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$	8	12.4 Electrostatic Discharge Caution.....	18
6.12 Noise Characteristics.....	9	12.5 Glossary.....	18
6.13 Operating Characteristics.....	9	13 Mechanical, Packaging, and Orderable	
6.14 Typical Characteristics.....	10	Information	18
7 Parameter Measurement Information	11		

4 Revision History

DATE	REVISION	NOTES
December 2022	*	Initial Release

5 Pin Configuration and Functions

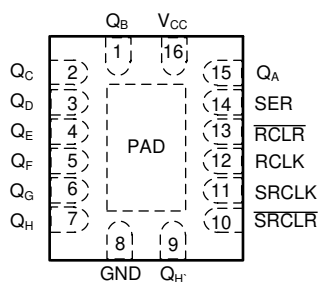


图 5-1. D, DB, or PW Package 16-Pin SOIC, SSOP, or TSSOP (Top View)

表 5-1. Pin Functions

PIN		TYPE ⁽¹⁾	DESCRIPTION
NAME	NO.		
Q _B	1	O	Output B
Q _C	2	O	Output C
Q _D	3	O	Output D
Q _E	4	O	Output E
Q _F	5	O	Output F
Q _G	6	O	Output G
Q _H	7	O	Output H
GND	8	G	Ground pin
Q _H '	9	O	Q _H inverted
SRCLR	10	I	Serial clear
SRCLK	11	I	Serial clock
RCLK	12	I	Storage clock
RCLR	13	I	Storage clear
SER	14	I	Serial input
Q _A	15	O	Output A
V _{CC}	16	P	Power pin
Thermal Pad		-	Thermal Pad ⁽¹⁾

(1) I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) ⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage		-0.5	7	V
V _I	Input voltage ⁽²⁾		-0.5	7	V
V _O	Voltage range applied to any output in the high-impedance or power-off state ⁽²⁾		-0.5	7	V
V _O	Output voltage ^{(2) (3)}		-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	V _I < 0	-20		mA
I _{OK}	Output clamp current	V _O < 0	-50		mA
I _O	Continuous output current	V _O = 0 to V _{CC}	-25	25	mA
T _{stg}	Storage temperature		-65	150	°C

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the Recommended Operating Conditions but within the *Absolute Maximum Ratings*, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
- (3) The value is limited to 5.5 V maximum.

6.2 ESD Ratings

		VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human body model (HBM), per AEC Q100-002 HBM ESD Classification Level 2 ⁽¹⁾	V
		Charged device model (CDM), per AEC Q100-011 CDM ESD Classification Level C6	

- (1) AEC Q100-002 indicate that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage		2	5.5	V
V _{IH}	High-level input voltage	V _{CC} = 2 V	1.5		V
		V _{CC} = 2.3 V to 2.7 V	V _{CC} × 0.7		
		V _{CC} = 3 V to 3.6 V	V _{CC} × 0.7		
		V _{CC} = 4.5 V to 5.5 V	V _{CC} × 0.7		
V _{IL}	Low-level input voltage	V _{CC} = 2 V		0.5	V
		V _{CC} = 2.3 V to 2.7 V		V _{CC} × 0.3	
		V _{CC} = 3 V to 3.6 V		V _{CC} × 0.3	
		V _{CC} = 4.5 V to 5.5 V		V _{CC} × 0.3	
V _I	Input voltage		0	5.5	V
V _O	Output voltage		0	V _{CC}	V
I _{OH}	High-level input current	V _{CC} = 2 V		–50	μA
		V _{CC} = 2.3 V to 2.7 V		–2	
		V _{CC} = 3 V to 3.6 V		6	
		V _{CC} = 4.5 V to 5.5 V		–12	
I _{OL}	Low-level output current	V _{CC} = 2 V		50	μA
		V _{CC} = 2.3 V to 2.7 V		2	
		V _{CC} = 3 V to 3.6 V		6	
		V _{CC} = 4.5 V to 5.5 V		12	
Δt/Δv	Input transition rise or fall rate	V _{CC} = 2.3 V to 2.7 V		200	ns/V
		V _{CC} = 3 V to 3.6 V		100	
		V _{CC} = 4.5 V to 5.5 V		20	
T _A	Operating free-air temperature		–40	125	°C

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report *Implications of Slow or Floating CMOS Inputs*, [SCBA004](#).

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		SN74LV594A-Q1	UNIT
		BQB (WQFN)	
		16 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	86.0	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	82.6	
R _{θJB}	Junction-to-board thermal resistance	54.9	
ψ _{JT}	Junction-to-top characterization parameter	9.5	
ψ _{JB}	Junction-to-board characterization parameter	54.9	
ψ _{JC}	Junction-to-bottom characterization parameter	32.5	

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).

6.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	UNIT
V _{OH}	I _{OH} = −50 μA	2 V to 5.5 V	V _{CC} − 0.1			V
	I _{OH} = −2 μA	2.3 V	2			
	I _{OH} = −6 μA	3 V	2.48			
	I _{OH} = −12 μA	4.5 V	3.8			
V _{OL}	I _{OH} = −50 μA	2 V to 5.5 V	0.1			V
	I _{OH} = −2 μA	2.3 V	0.4			
	I _{OH} = −6 μA	3 V	0.44			
	I _{OH} = −12 μA	4.5 V	0.55			
I _I	V _I = 5.5 V or GND	0 to 5.5 V	±1			μA
I _{CC}	V _I = V _{CC} of GND, I _O = 0	5.5 V	20			μA
I _{off}	V _I or V _O = 0 to 5.5 V	0	5			μA
C _i	V _I = V _{CC} or GND	3.3 V	3.5			pF

6.6 Switching Characteristics: $V_{CC} = 2.5\ V \pm 0.2\ V$

over recommended operating free-air temperature range (unless otherwise noted). See [Figure 6-1](#).

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T _A = 25°C			−40°C TO 125°C		UNIT
				MIN	TYP	MAX	MIN	MAX	
f _{max}			C _L = 15 pF	65	80		35		MHz
			C _L = 50 pF	60	70		30		
t _{PLH}	SRCLK	Q _A − Q _H	C _L = 15 pF		6.4	10.6	1	12.5	ns
t _{PHL}					6.3	10.4	1	12.5	
t _{PLH}		Q _{H'}			7.4	12.1	1	15	
t _{PHL}				7.2	11.6	1	15		
t _{PHL}	RCLK	Q _A − Q _H			7.9	12.7	1	15.5	
		Q _{H'}			7.4	11.9	1	15.5	
t _{PLH}	SRCLR	Q _A − Q _H	C _L = 50 pF		9.5	14.1	1	17	ns
t _{PHL}					10.8	15.5	1	19.5	
t _{PLH}	Q _{H'}			10.6	15.7	1	18.5		
t _{PHL}				11.3	16.1	1	20.5		
t _{PHL}	RCLR	Q _A − Q _H			12.1	17.4	1	21	
		Q _{H'}			11.6	16.5	1	20.6	

6.7 Switching Characteristics: $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$

over recommended operating free-air temperature range (unless otherwise noted). See [Figure 6-1](#).

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T _A = 25°C			−40°C TO 125°C		UNIT	
				MIN	TYP	MAX	MIN	MAX		
f _{max}			C _L = 15 pF	80	120		60		MHz	
			C _L = 50 pF	55	105		40			
t _{PLH}	SRCLK	Q _A − Q _H	C _L = 15 pF		4.6	8	1	10.5	ns	
t _{PHL}					4.9	8.2	1	10.5		
t _{PLH}		Q _{H'}			5.4	9.1	1	11.5		
t _{PHL}				5.5	9.2	1	11.6			
	RCLK			Q _A − Q _H		6	9.8	1		12.1
t _{PHL}				Q _{H'}		5.6	9.2	1		12
t _{PLH}	SRCLR	Q _A − Q _H	C _L = 50 pF				1	12.5	ns	
t _{PHL}							1	15		
t _{PLH}		Q _{H'}					1	14		
t _{PHL}						1	15.5			
	RCLR			Q _A − Q _H			1	16.1		
t _{PHL}				Q _{H'}			1	16		

6.8 Switching Characteristics: $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$

over recommended operating free-air temperature range (unless otherwise noted). See [Figure 6-1](#).

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T _A = 25°C			−40°C TO 125°C		UNIT
				MIN	TYP	MAX			
f _{max}			C _L = 15 pF	135	170		105		MHZ
			C _L = 50 pF	120	140		85		
t _{PLH}	SRCLK	Q _A − Q _H	C _L = 15 pF		3.3	6.2	1	8	ns
t _{PHL}					3.7	6.5	1	8.5	
t _{PLH}		Q _{H'}			3.7	6.8	1	8.5	
t _{PHL}	RCLK			Q _A − Q _H		4.1	7.2	1	
t _{PHL}		Q _{H'}				4.5	7.6	1	
t _{PHL}						4.1	7.1	1	
t _{PLH}	SRCLR	Q _A − Q _H	C _L = 50 pF		4.9	7.8	1	9.6	ns
t _{PHL}					5.8	8.9	1	11	
t _{PLH}		Q _{H'}			5.5	8.6	1	10.5	
t _{PHL}	RCLR			Q _A − Q _H		6	9.2	1	
t _{PHL}		Q _{H'}				6.6	10	1	
t _{PHL}						6	9.2	1	

6.9 Timing Requirements: $V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$

over recommended operating free-air temperature range. See [6-1](#).

			T _A = 25°C		−40°C TO 125°C		UNIT
			MIN	MAX	MIN	MAX	
t _w	Pulse duration	RCLK or SRCLK high or low	7		8.5		ns
		RCKR or SCRCLR low	6		7.5		
t _{su}	Setup time	SER before SRCLK ↑	5.5		6		ns
		SRCLK ↑ before RCLK ↑	8		10		
		SCRCLR low before RCLK ↑ ⁽¹⁾	8.5		10.5		
		SRCLR high (inactive) before SRCLK ↑	6		7.5		
		RCLK high (inactive) before RCLK ↑	6.7		8.5		
t _h	Hold time	SER after SRCLK ↑	1.5		2		ns

- (1) This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

6.10 Timing Requirements: $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$

over recommended operating free-air temperature range. See [6-1](#).

			T _A = 25°C		−40°C TO 125°C		UNIT
			MIN	MAX	MIN	MAX	
t _w	Pulse duration	RCLK or SRCLK high or low	5.5		6.5		ns
		RCKR or SCRCLR low	5		6		
t _{su}	Setup time	SER before SRCLK ↑	3.5		4		ns
		SRCLK ↑ before RCLK ↑	8		9.5		
		SCRCLR low before RCLK ↑ (1)	8		10		
		SRCLR high (inactive) before SRCLK ↑	4.2		5.5		
		RCLK high (inactive) before RCLK ↑	4.6		6		
t _h	Hold time	SER after SRCLK ↑	1.5		2		ns

- (1) This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

6.11 Timing Requirements: $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$

over recommended operating free-air temperature range. See [6-1](#).

		T _A = 25°C		−40°C TO 125°C		UNIT
		MIN	MAX	MIN	MAX	
t _w	Pulse duration	RCLK or SRCLK high or low		5		ns
		RCKR or SCRCLR low		5.2		
t _{su}	Setup time	SER before SRCLK ↑		3		ns
		SRCLK ↑ before RCLK ↑		5		
		SCRCLR low before RCLK ↑ (1)		5		
		SRCLR high (inactive) before SRCLK ↑		2.9		
		RCLK high (inactive) before RCLK ↑		3.2		
t _h	Hold time	SER after SRCLK ↑		2		ns

- (1) This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

6.12 Noise Characteristics

over operating free-air temperature range (unless otherwise noted), $V_{CC} = 3.3\text{ V}$, $C_L = 50\text{ pF}$, $T_A = 25^\circ\text{C}$ ⁽¹⁾

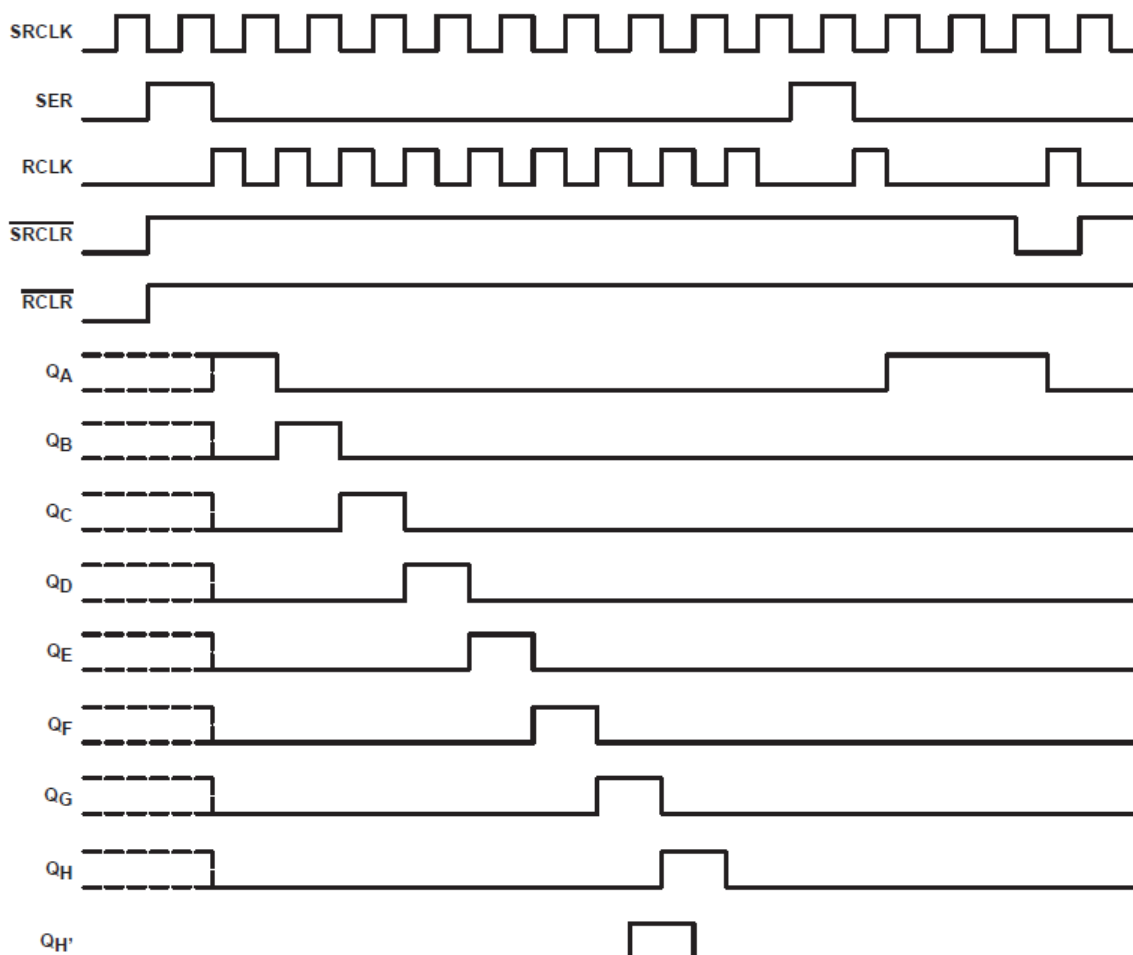
PARAMETER		MIN	TYP	MAX	UNIT
$V_{OL(P)}$	Quiet output, maximum dynamic V_{OL}		0.5	0.8	V
$V_{OL(V)}$	Quiet output, minimum dynamic V_{OL}		–0.1	–0.8	V
$V_{OH(V)}$	Quiet output, minimum dynamic V_{OH}		2.8		V
$V_{IH(V)}$	High-level dynamic input voltage	2.31			V
$V_{IL(V)}$	Low-level dynamic input voltage			0.99	V

(1) Characteristics are for surface-mount packages only.

6.13 Operating Characteristics

$T_A = 25^\circ\text{C}$

PARAMETER		TEST CONDITIONS	V_{CC}	TYP	UNIT
C_{pd}	Power dissipation capacitance	$f = 10\text{ MHz}$	3.3 V	93	pF
			5 V	112	



6-1. Timing Diagram

6.14 Typical Characteristics

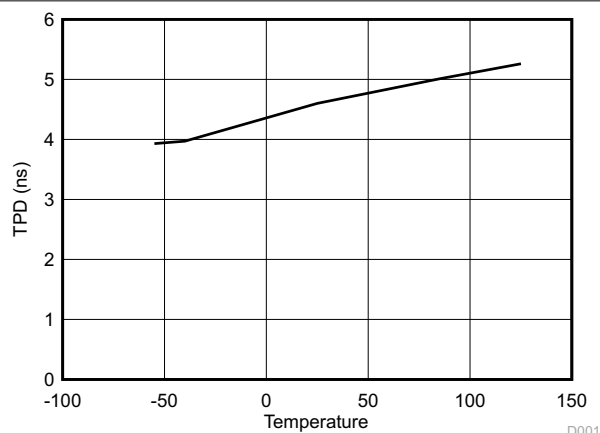


图 6-2. TPD vs. Temperature at 3.3 V

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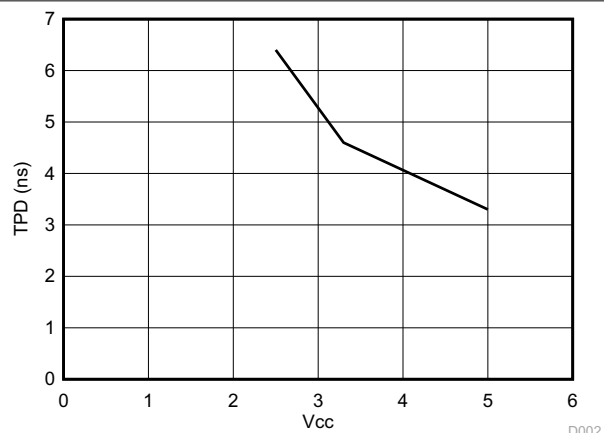
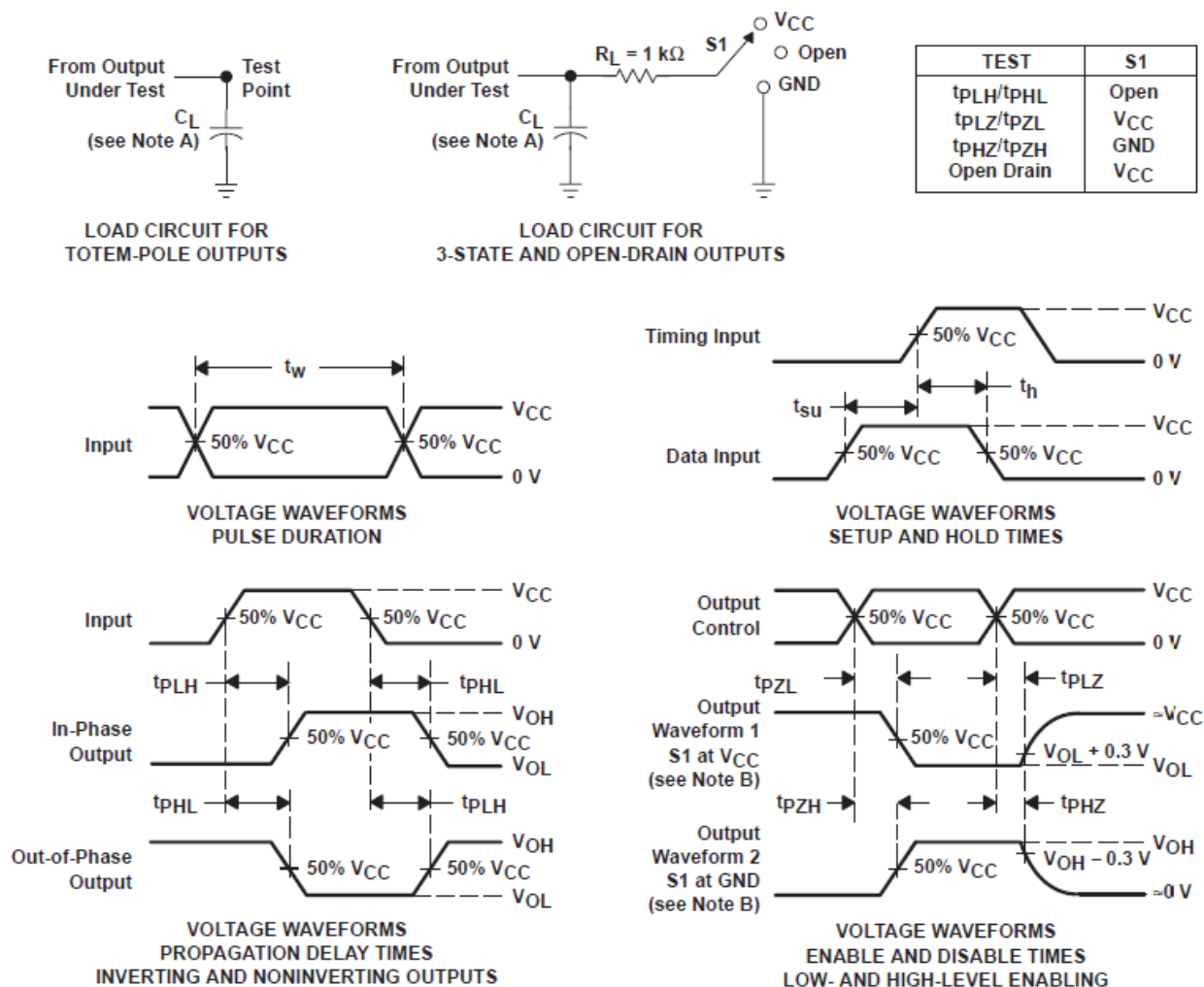


图 6-3. TPD vs. Vcc at 25°C

D002

7 Parameter Measurement Information



- NOTES:
- A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1\text{ MHz}$, $Z_O = 50\ \Omega$, $t_r \leq 3\text{ ns}$, $t_f \leq 3\text{ ns}$.
 - D. The outputs are measured one at a time, with one input transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PHL} and t_{PLH} are the same as t_{pd} .
 - H. All parameters and waveforms are not applicable to all devices.

7-1. Load Circuit and Voltage Waveforms

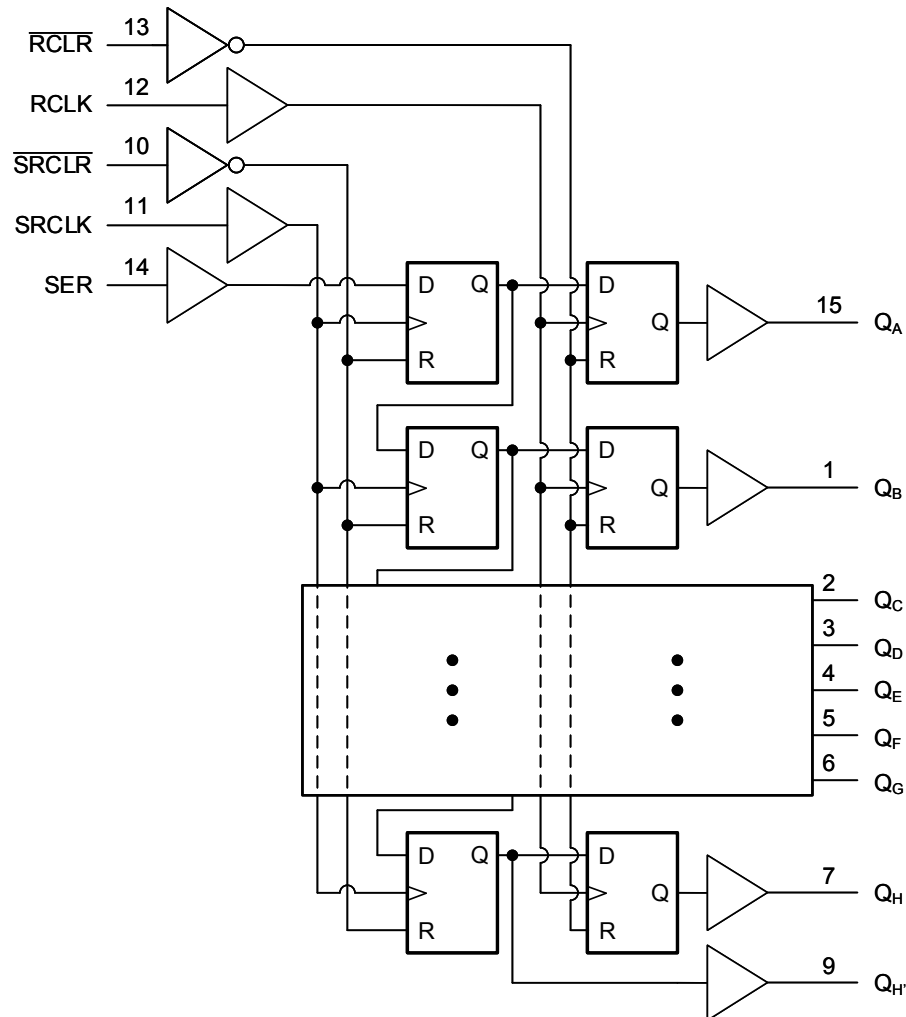
8 Detailed Description

8.1 Overview

The SN74LV594A-Q1 devices are 8-bit shift registers designed for 2-V to 5.5-V V_{CC} operation.

These devices contain an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. Separate clocks (RCLK, SRCLK) and direct overriding clear ($\overline{RCLR}$, $\overline{SRCLR}$) inputs are provided on the shift and storage registers. A serial output ($Q_{H'}$) is provided for cascading purposes. The shift-register (SRCLK) and storage-register (RCLK) clocks are positive-edge triggered. If the clocks are tied together, then the shift register always is one clock pulse ahead of the storage register.

8.2 Functional Block Diagram



8.3 Feature Description

The device's wide operating range allows it to be used in a variety of systems that use different logic levels. The low propagation delay allows fast switching and higher speeds of operation. In addition, the low ground bounce stabilizes the performance of non-switching outputs while another output is switching.

8.4 Device Functional Modes

表 8-1. Function Table

INPUTS					FUNCTION
SER	SRCLK	SRCLR	RCLK	RCLR	
X	X	L	X	X	Shift register is cleared.
L	↑	H	X	X	First stage of shift register goes low. Other stages store the data of previous stage, respectively.
H	↑	H	X	X	First stage of shift register goes high. Other stages store the data of previous stage, respectively.
L	↓	H	X	X	Shift register state is not changed.
X	X	X	X	L	Storage register is cleared.
X	X	X	↑	H	Shift register data is stored in the storage register.
X	X	X	↓	H	Storage register state is not changed.

9 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The SN74LV594A-Q1 is a low drive CMOS device that can be used for a multitude of bus interface type applications where output ringing is a concern. The low drive and slow edge rates will minimize overshoot and undershoot on the outputs.

9.2 Typical Application

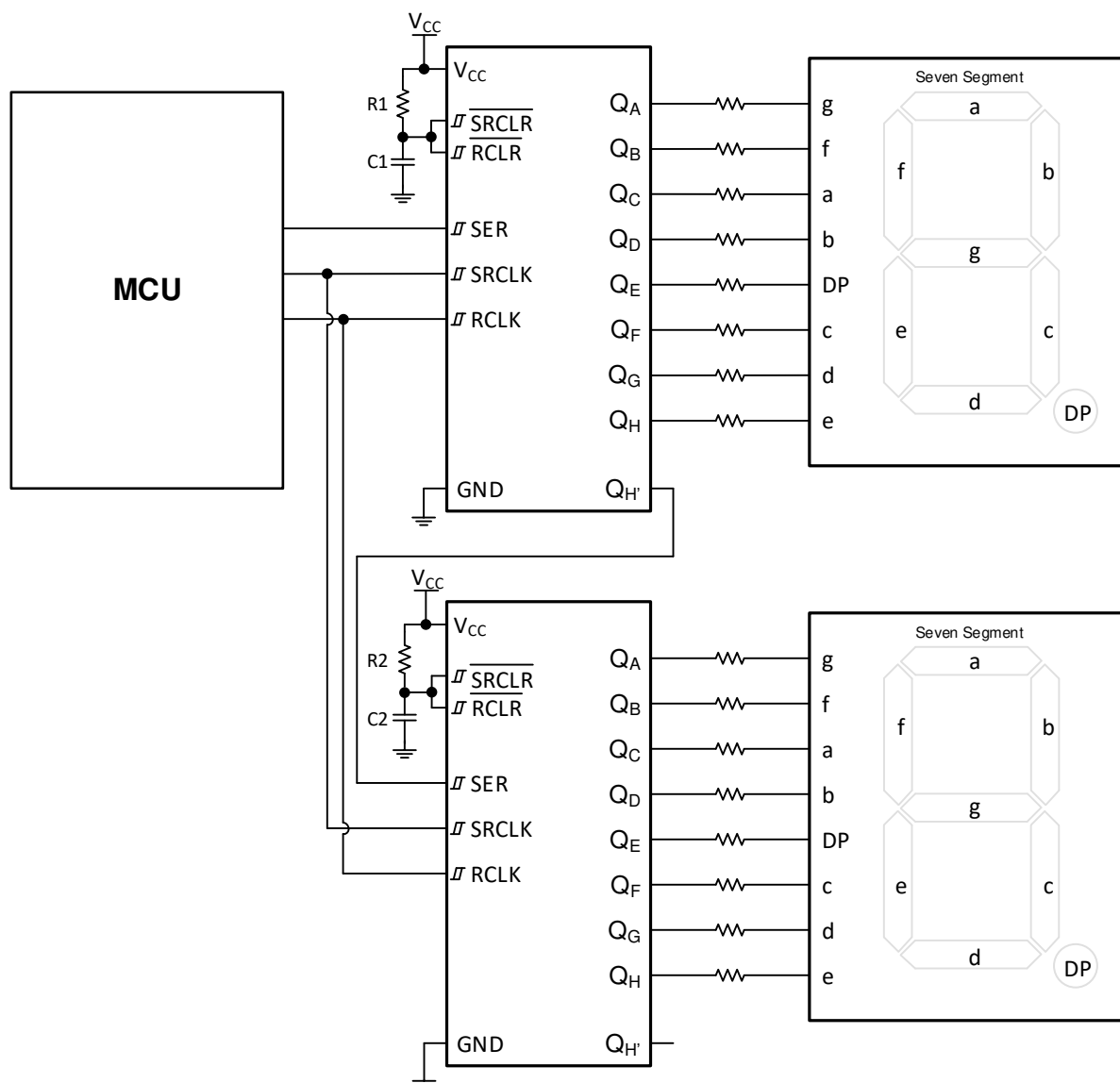


图 9-1. Typical Application Schematic

9.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads, so consider routing and load conditions to prevent ringing.

9.2.2 Detailed Design Procedure

- Recommended input conditions:
 - Rise time and fall time specs. See ($\Delta t/\Delta V$) in セクション 6.3.
 - Specified high and low levels. See (V_{IH} and V_{IL}) in セクション 6.3.
 - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid V_{CC} .
- Recommended output conditions:
 - Load currents should not exceed 25 mA per output and 50 mA total for the part.
 - Outputs should not be pulled above V_{CC} .

9.2.3 Application Curves

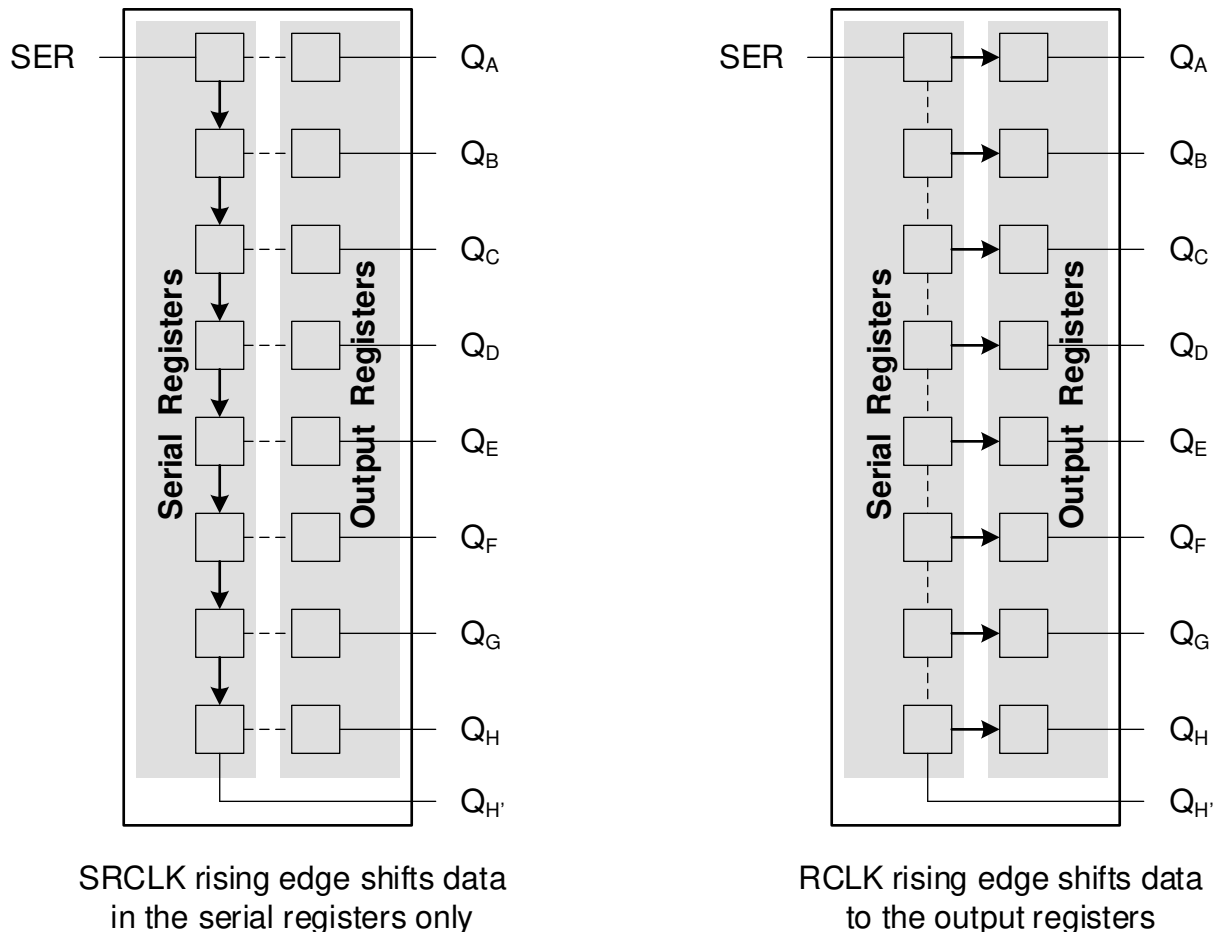


図 9-2. Simplified functional diagram showing clock operation

10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the [Recommended Operating Conditions](#). Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, TI recommends a 0.1- μ F capacitor and if there are multiple V_{CC} terminals then TI recommends a 0.01- μ F or 0.022- μ F capacitor for each power terminal. Multiple bypass capacitors can be paralleled to reject different frequencies of noise. Frequencies of 0.1 μ F and 1 μ F are commonly used in parallel. The bypass capacitor should be installed as close as possible to the power terminal for best results.

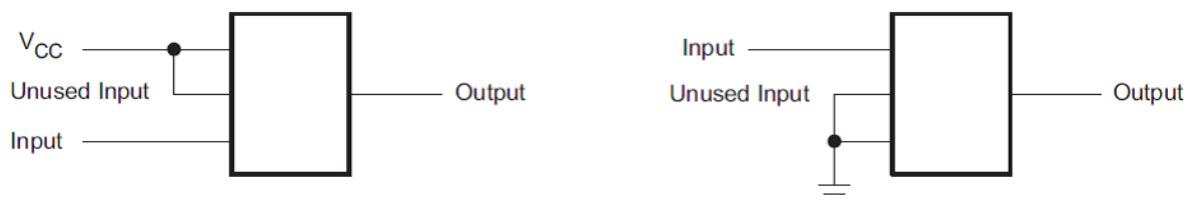
11 Layout

11.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only three of the four buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified below are the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} whichever make more sense or is more convenient. Floating outputs is generally acceptable, unless the part is a transceiver. If the transceiver has an output enable pin, then it will disable the outputs section of the part when asserted. This will not disable the input section of the I.O's so they also cannot float when disabled.

11.2 Layout Example



✎ 11-1. Layout Example

12 Device and Documentation Support

12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](https://www.ti.com). Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.2 サポート・リソース

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12.3 Trademarks

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12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.5 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
SN74LV594AQWBQBRQ1	Active	Production	WQFN (BQB) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV594Q
SN74LV594AQWBQBRQ1.A	Active	Production	WQFN (BQB) 16	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV594Q

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN74LV594A-Q1 :

- Catalog : [SN74LV594A](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

GENERIC PACKAGE VIEW

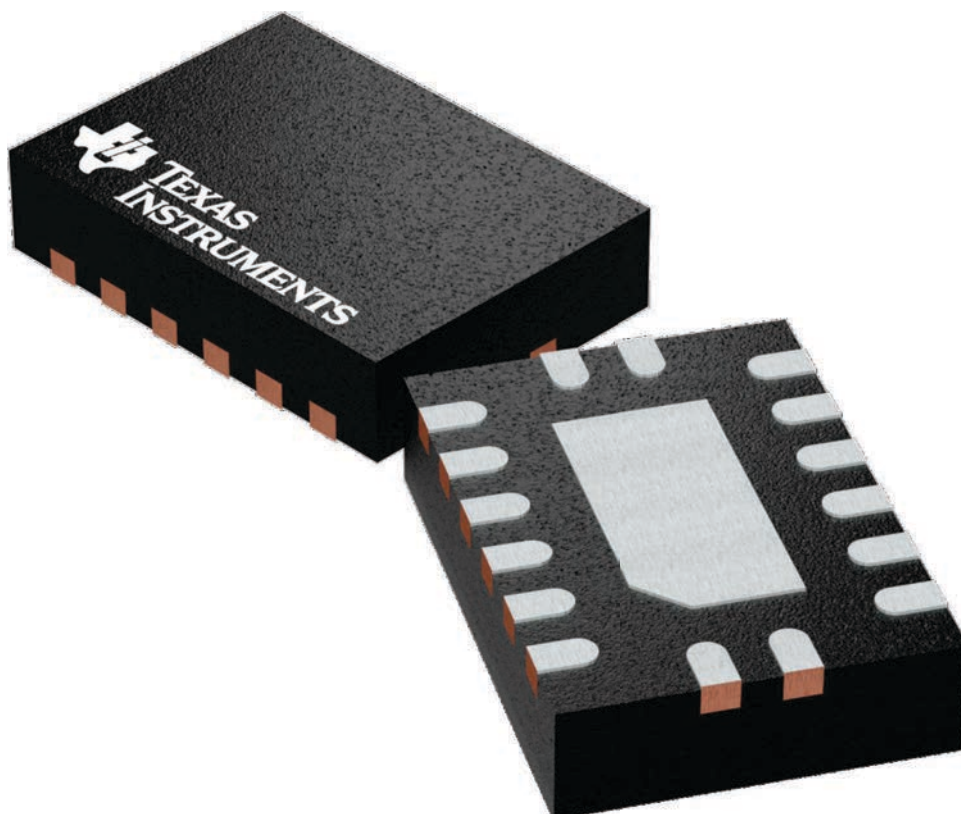
BQB 16

WQFN - 0.8 mm max height

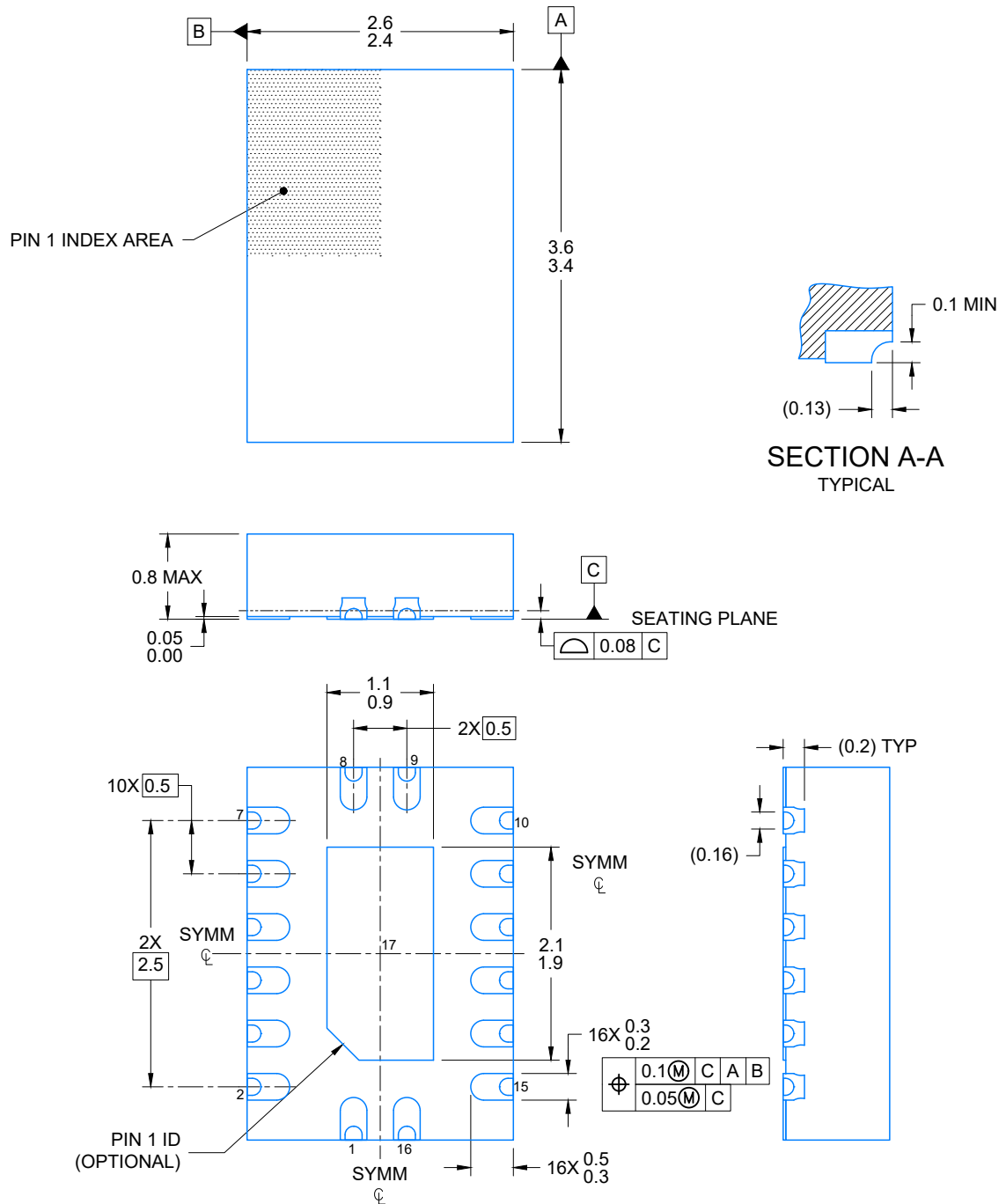
2.5 x 3.5, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



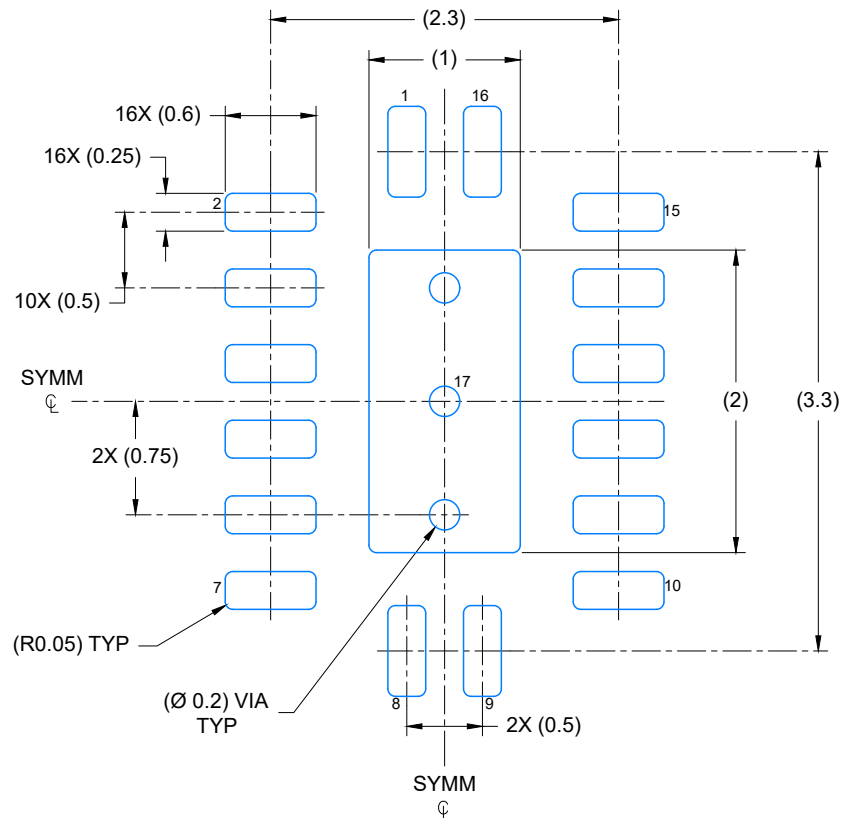
4226161/A



4226135/A 08/2020

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.

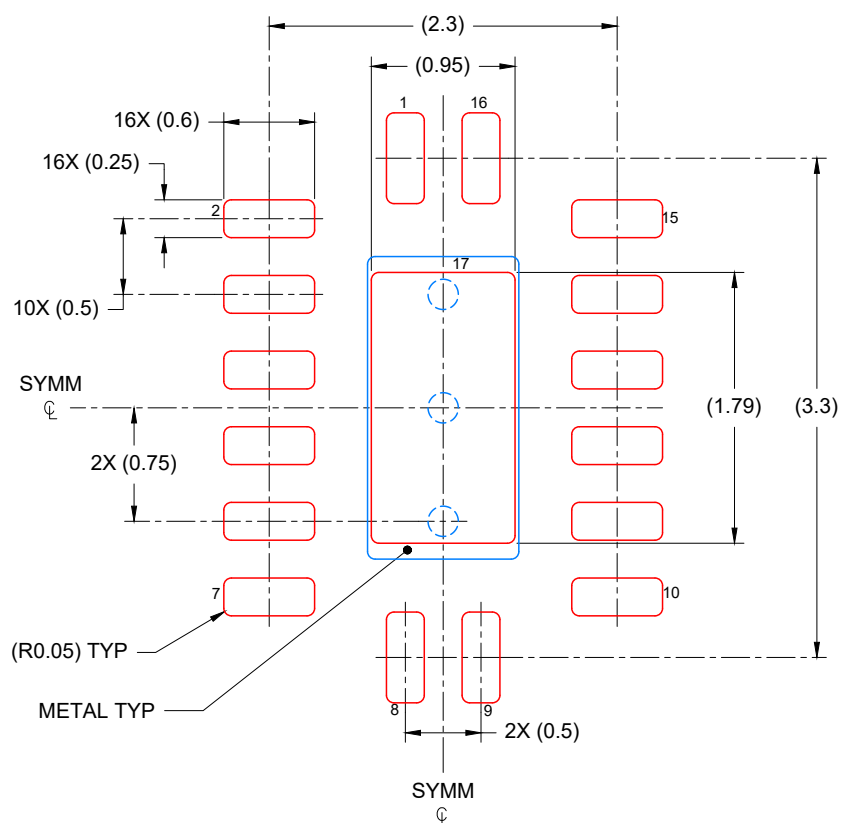


LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 20X

4226135/A 08/2020

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
85% PRINTED COVERAGE BY AREA
SCALE: 20X

4226135/A 08/2020

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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